

## N-Channel 20-V (D-S) MOSFET

#### **Description**

The MS20N06S is the highest performance trench N-ch MOSFETs with extreme high cell density, which provide excellent R<sub>DS(ON)</sub> and gate charge for most of the small power switching and load switch applications.

The device meets the RoHS and Green Product requirement with full function reliability approved.

#### **Features**

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- Green Device Available

#### **Typical Applications**

- Notebook
- Load Switch
- Hand-held Instrument

Package type: SOT-23

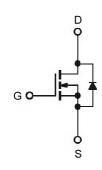
#### **Packing & Order Information**

3,000/Reel

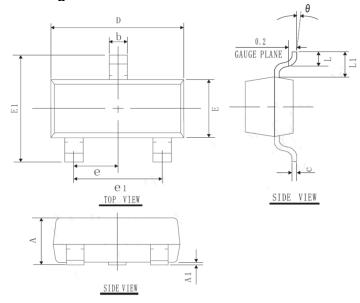


RoHS Compliant

#### **Graphic Symbol**

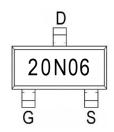


#### **Package Dimension**



REF.	Millimeter		REF.	Millimeter		
	Min.	Max.	KEF.	Min.	Max.	
Α	0.90	1.10	E1	2.30	2.50	
A1	0.00	0.10	L	0.30	0.50	
b	0.30	0.50	Θ	0°	10°	
С	0.08	0.15	L1	0.55 Ref.		
D	2.80	3.00	е	0.95 Typ.		
E	1.20	1.40	e1	1.95 Ref.		

#### Marking





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#### **MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS**

Absolute Maximum Ratings (unless otherwise specified)					
Symbol	Parameter	Value	Units		
$V_{\text{DS}}$	Drain-Source Voltage	20	V		
V <sub>G</sub> S	Gate-Source Voltage	±12	V		
I_	Continuous Drain Current <sup>1</sup> (T <sub>A</sub> =25°C)	6	А		
I <sub>D</sub>	Continuous Drain Current <sup>1</sup> (T <sub>A</sub> =70°C)	5	Α		
I <sub>DM</sub>	Pulsed Drain Current <sup>2</sup> (T <sub>A</sub> =25°C)	17	Α		
P <sub>D</sub>	Power Dissipation <sup>3</sup> (T <sub>A</sub> =25°C)	1	W		
T <sub>J</sub> /T <sub>STG</sub>	Operating Junction and Storage Temperature	-55 to +150	°C		

Thermal Resistance Ratings					
Symbol	Parameter	Maximum	Units		
Reja	Maximum Junction-to-Ambient <sup>3</sup>	125	°C/W		

Electrical Characteristics(T」=25°C unless otherwise specified)						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
$V_{\text{GS (th)}}$	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	0.45	-	1.0	V
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	20	-	-	V
<b>g</b> fs	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =4A	-	30	-	S
Igss	Gate-Source Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±12V	-	-	±100	nA
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =16V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C	-	-	1	μA
		V <sub>DS</sub> =16V, V <sub>GS</sub> =0V, T <sub>J</sub> =55°C			5	
R <sub>DS</sub> (on)	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =4.5V, I <sub>D</sub> =4.0A	-	21	26	mΩ
		V <sub>GS</sub> =2.5V, I <sub>D</sub> =3.0A		28	35	
		V <sub>GS</sub> =1.8V, I <sub>D</sub> =2.0A		40	50	
V <sub>SD</sub>	Diode Forward Voltage <sup>2</sup>	Is=1.0A, V <sub>G</sub> s=0V, T <sub>J</sub> =25°C	-	-	1.2	V
Is	Continuous Source Current <sup>1,4</sup> (Diode)	V V 0V Farra Ourrant	-	-	6	_
I <sub>SM</sub>	Pulsed Source Current <sup>2,4</sup> (Diode)	V <sub>G</sub> =V <sub>D</sub> =0V, Force Current	-	-	17	Α

#### **Notes**

- 1. Surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2. The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%.
- 3. The power dissipation is limited by 150  $^{\circ}\text{C}~$  junction temperature.
- 4. The data is theoretically the same as I<sub>D</sub> and I<sub>DM</sub>, in real applications, should be limited by total power dissipation.



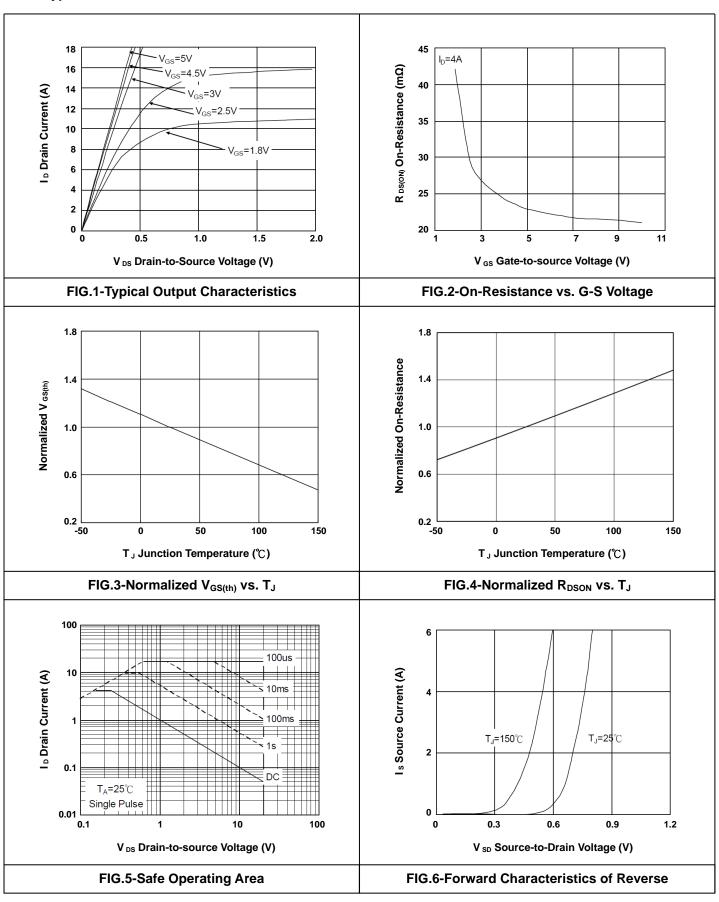
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Dynamic and switching Characteristics						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Qg	Total Gate Charge <sup>2</sup>	V <sub>DS</sub> =15V		8.6		
Qgs	Gate-Source Charge	I <sub>D</sub> =4A		1.37		nC
Qgd	Gate-Drain Charge	V <sub>GS</sub> =4.5V		2.3		
td(on)	Turn-On Delay Time <sup>2</sup>	V <sub>DS</sub> =10V		5.2		
tr	Rise Time	I <sub>D</sub> =4A		34		
td(off)	Turn-Off Delay Time	V <sub>GS</sub> =4.5V		23		ns
tf	Fall Time	R <sub>G</sub> =3.3Ω		9.2		
Ciss	Input Capacitance	V <sub>DS</sub> =15V		670		
Coss	Output Capacitance	V <sub>GS</sub> =0V		75		pF
Crss	Reverse Transfer Capacitance	f =1.0MHz		68		1



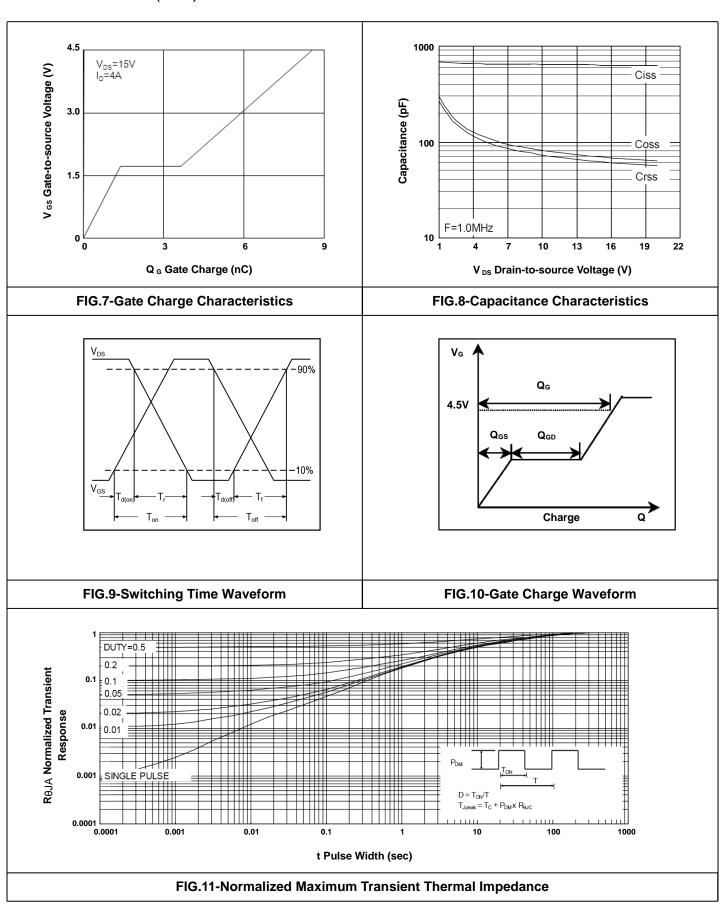
## N-Channel 20-V (D-S) MOSFET

• Typical Electrical Characteristics





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